Thermodynamic limits for approximate MEMS memory devices

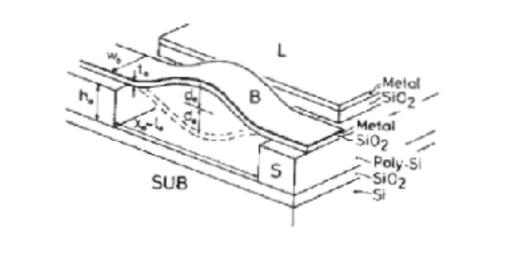
Igor Neri, Miquel López-Suárez and Luca Gammaitoni 3rd Workshop On Approximate Computing, Stockholm, January 25, 2017





MEMS Memory Devices

HÄLG: MICRO-ELECTRO-MECHANICAL NONVOLATILE MEMORY CELL





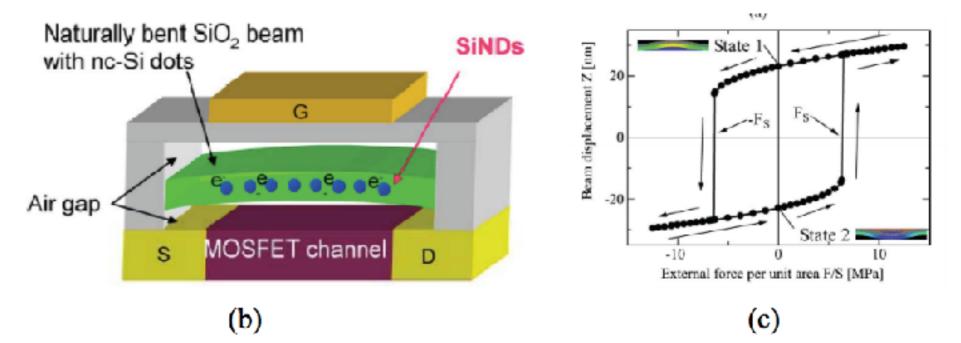
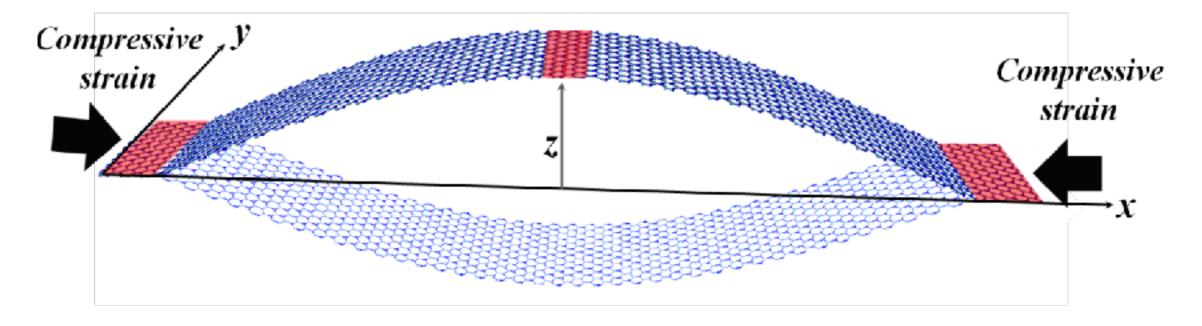


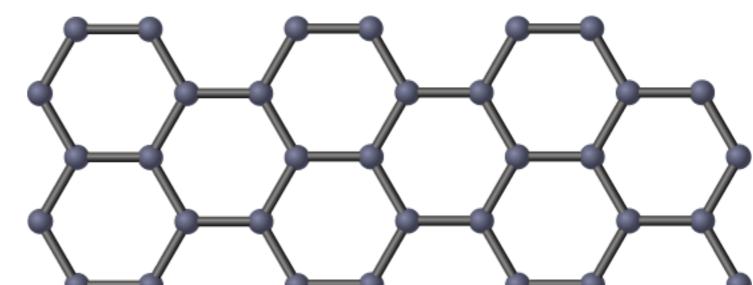
Figure 1: (a) Halg's and (b) Oda's bistable micro/nano-electro-mechanical memory concepts. (c) mechanical hysteresis in device (b).

Ionescu, Adrian M. "Nano-Electro-Mechanical (NEM) Memory Devices." Emerging Nanoelectronic Devices (2014): 123-136.

NEMS Memory Devices

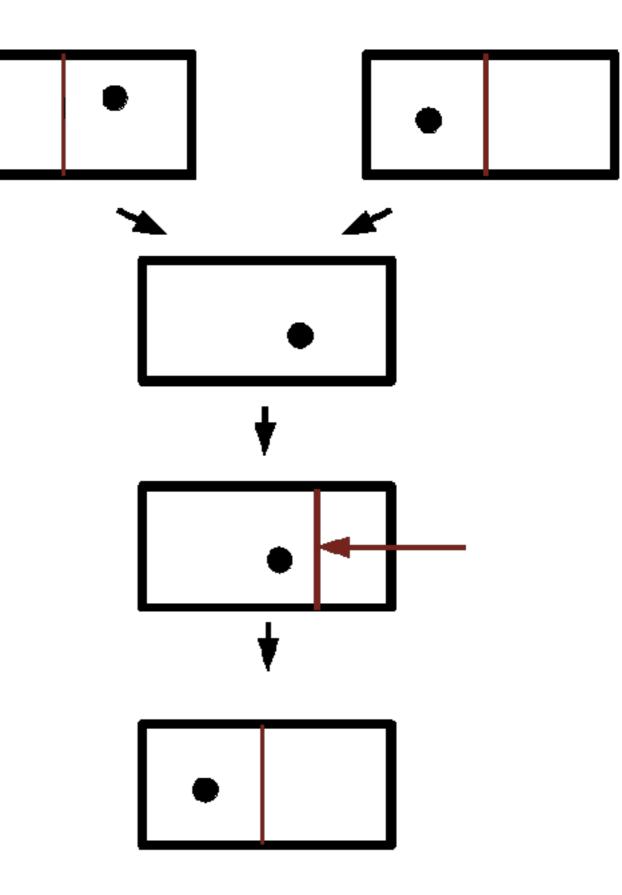


Neri, I., et al. "Reset and switch protocols at Landauer limit in a graphene buckled ribbon." EPL (Europhysics Letters) 111.1 (2015): 10004.



Landauer principle

- Minimum amount of energy required greater than zero
- Let assume the operation of bit reset
- # of initial states: 2
- # of final states: 1



Landauer principle

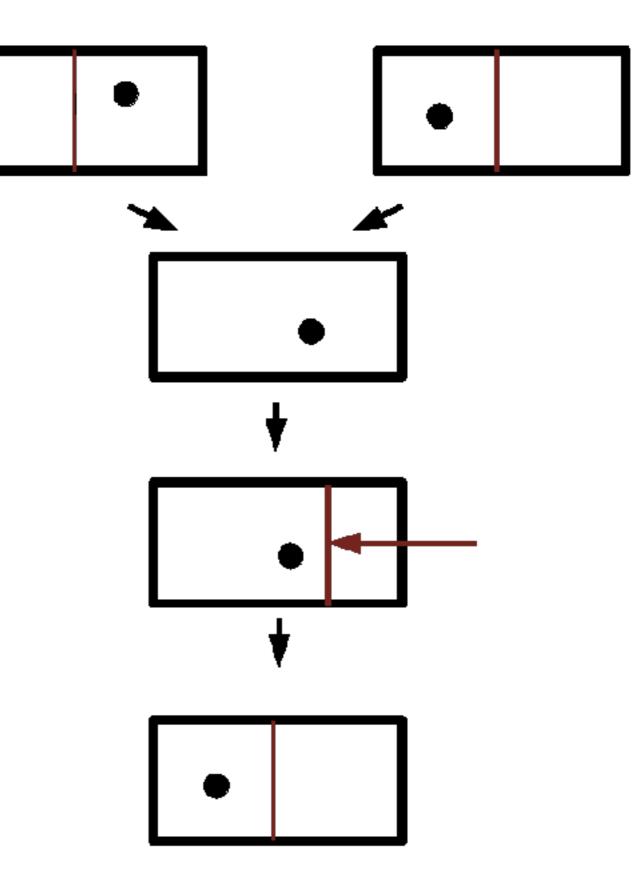
 $S = k_B \log W$ $Q \le T\Delta S$

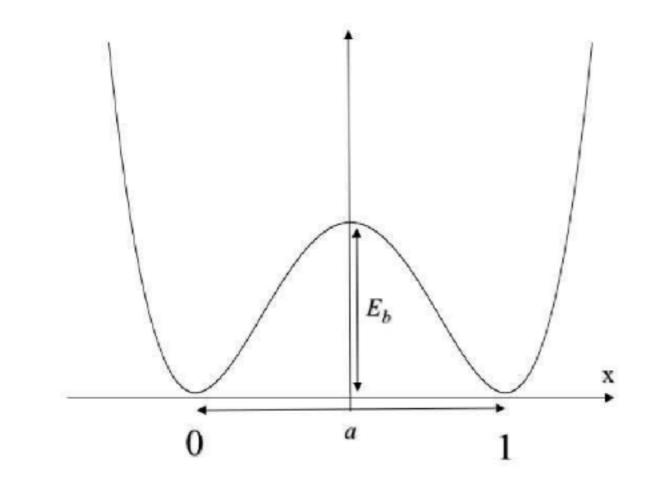
- Initial condition: two possible states $S_i = k_B \log 2$
- Final condition: one possible state $S_f = k_B \log 1$

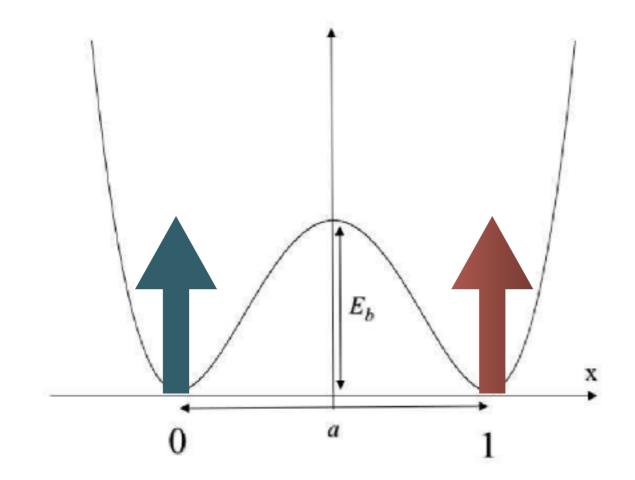
$$\Delta S = S_f - S_i = -k_B \log 2$$

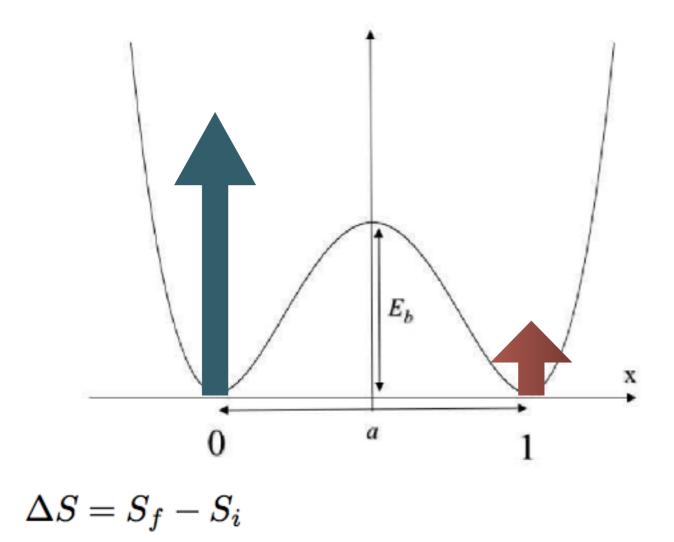
Heat produced

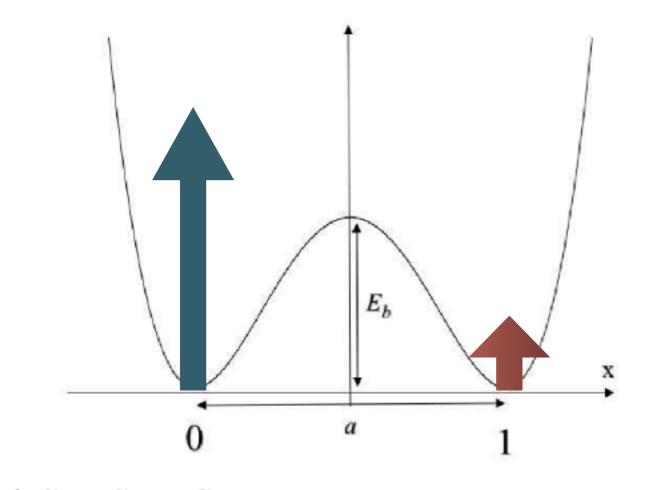
$$Q \le T\Delta S = -k_B T \log 2$$



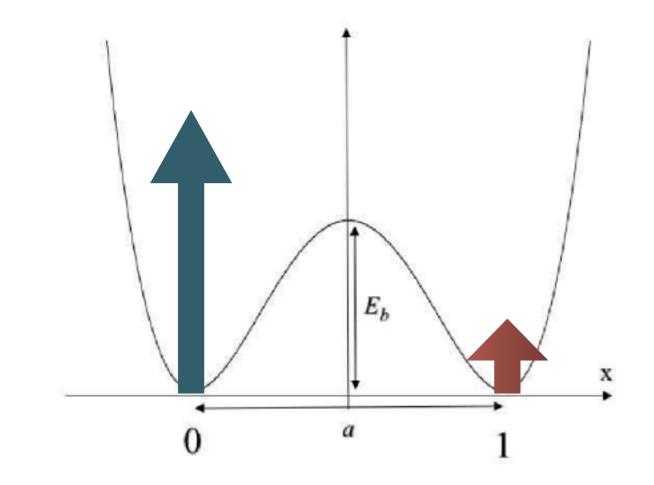






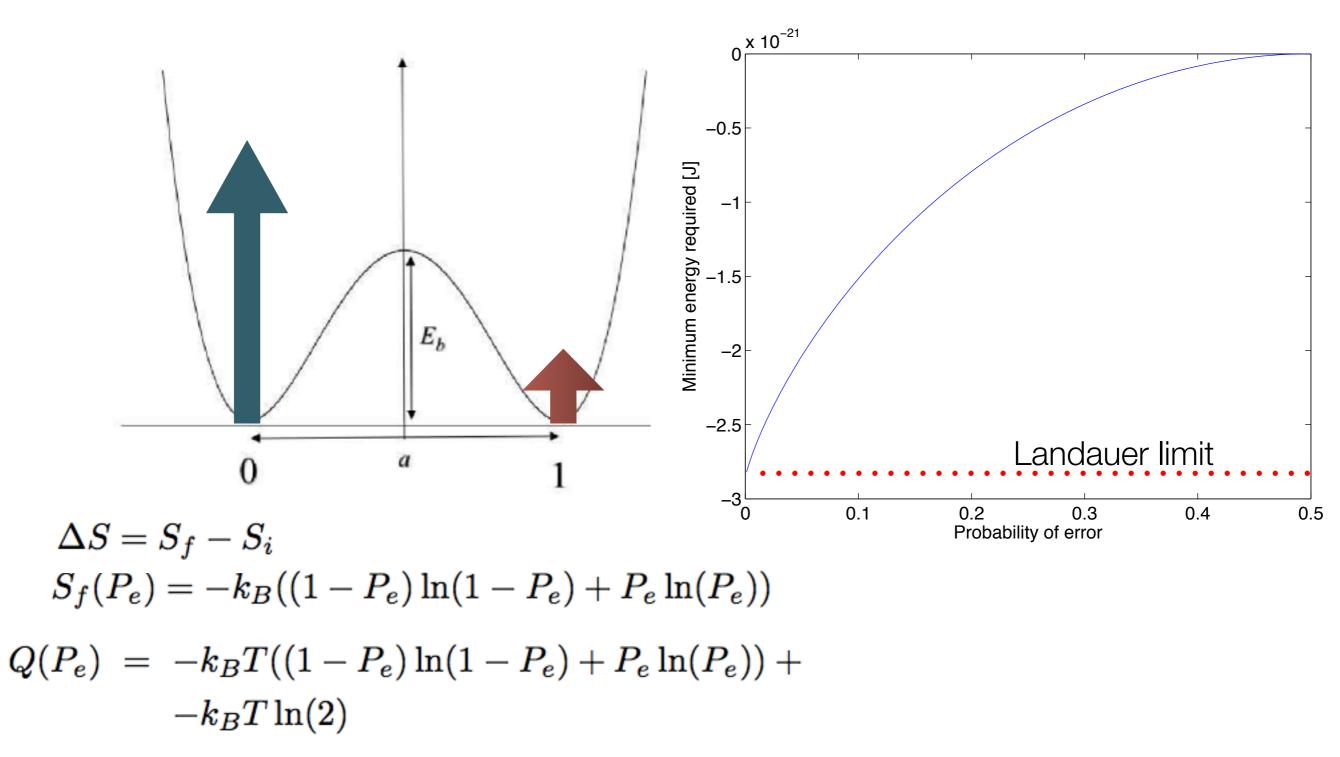


 $\Delta S = S_f - S_i$ $S_f(P_e) = -k_B((1 - P_e)\ln(1 - P_e) + P_e\ln(P_e))$

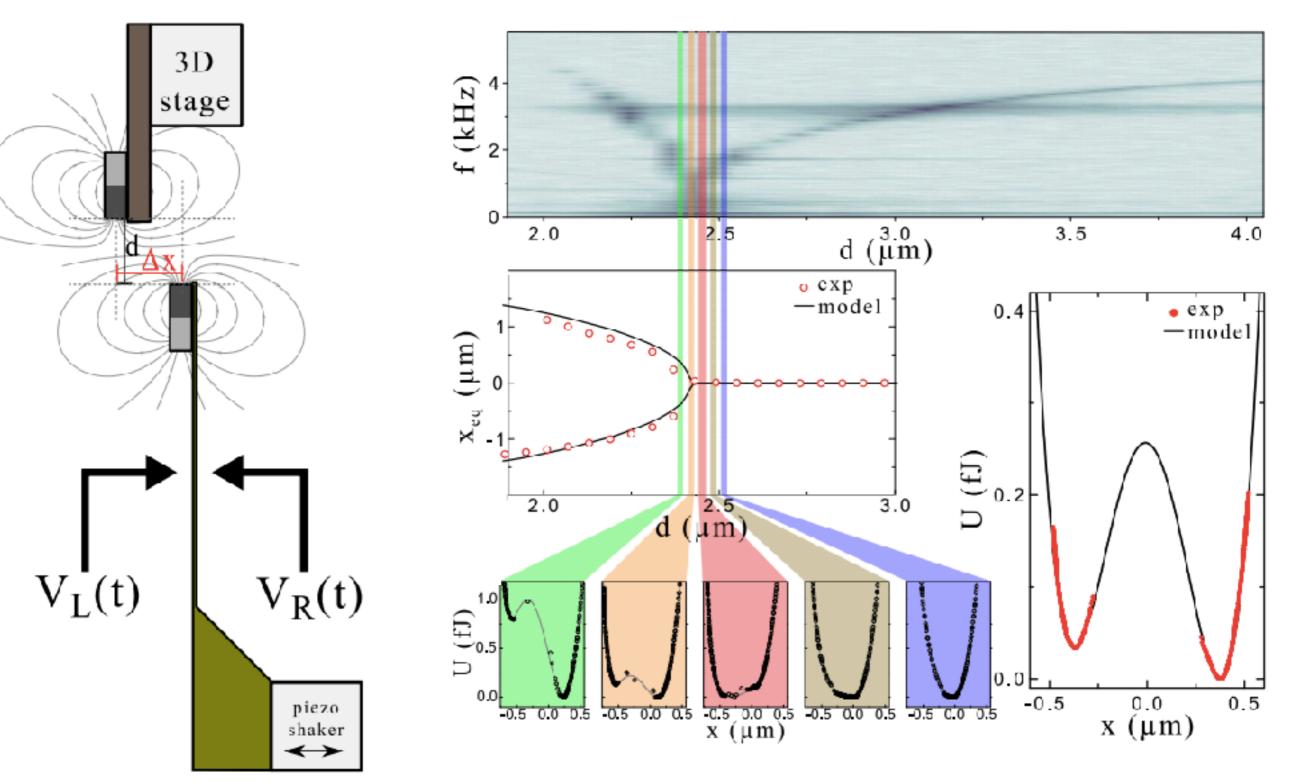


 $egin{aligned} \Delta S &= S_f - S_i \ S_f(P_e) &= -k_B((1-P_e)\ln(1-P_e) + P_e\ln(P_e)) \end{aligned}$ $Q(P_e) &= -k_BT((1-P_e)\ln(1-P_e) + P_e\ln(P_e)) + \end{aligned}$

 $(r_e) = -\kappa_B T ((1 - r_e) \ln(1 - r_e) + r_e \ln(r_e)) + -k_B T \ln(2)$

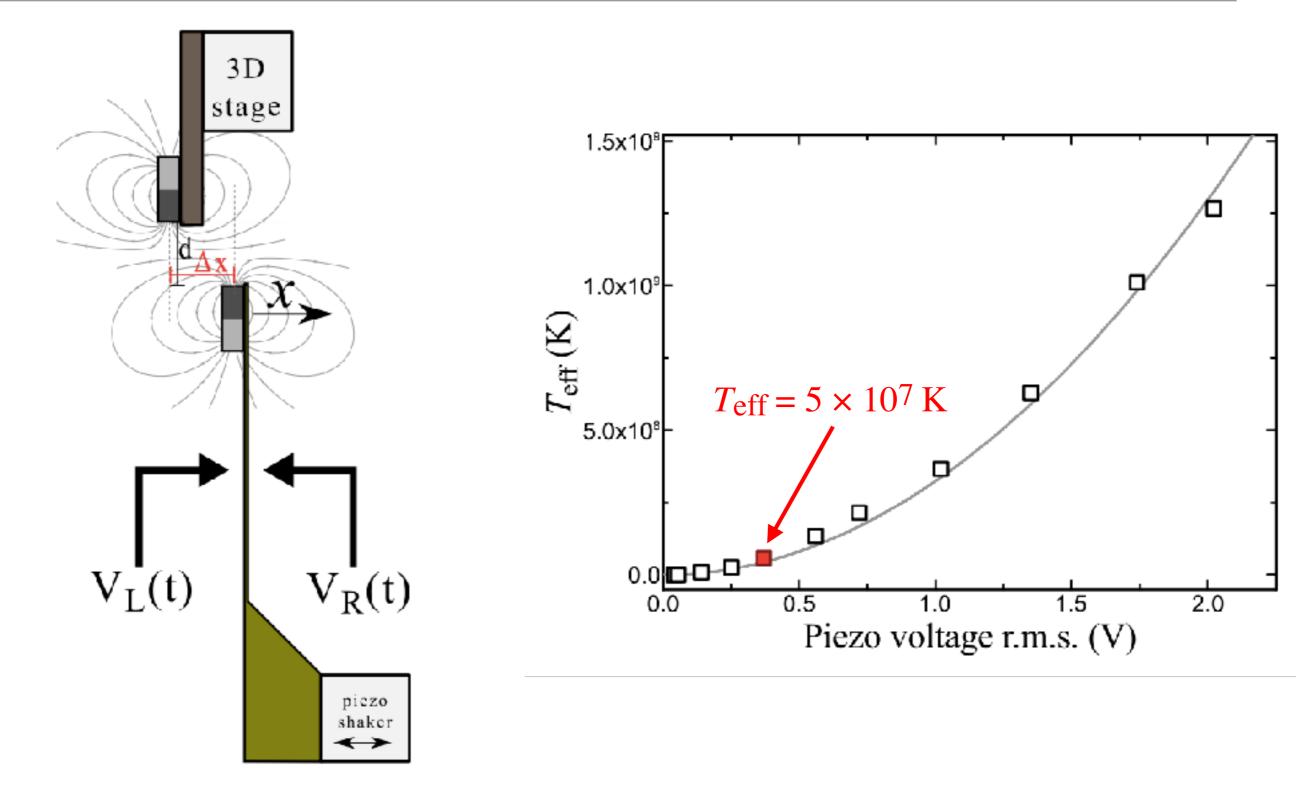


Micro-electromechanical memory bit based on magnetic repulsion

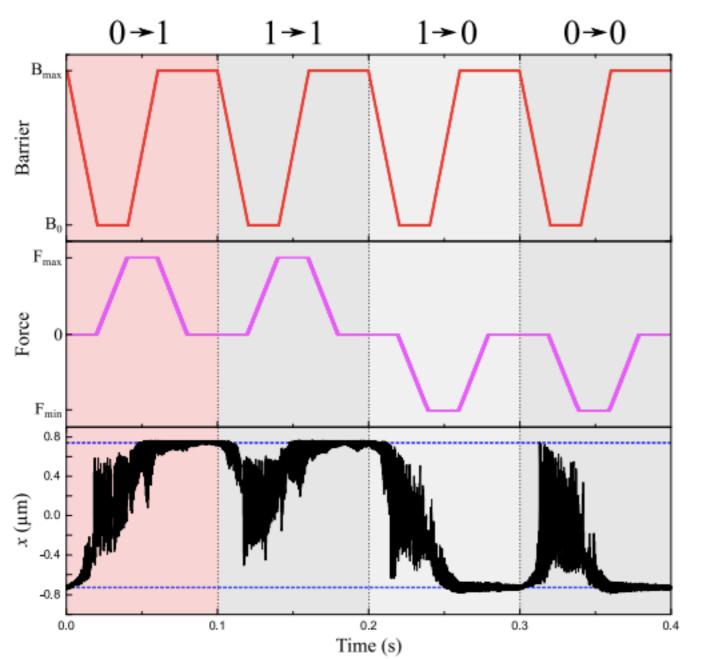


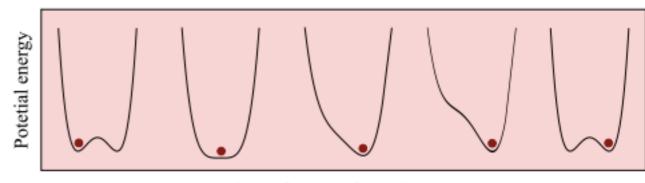
Micro-electromechanical memory bit based on magnetic repulsion, López-Suárez, Miquel and Neri, Igor, Applied Physics Letters, 109, 133505 (2016)

Micro-electromechanical memory bit based on magnetic repulsion



Reset protocol



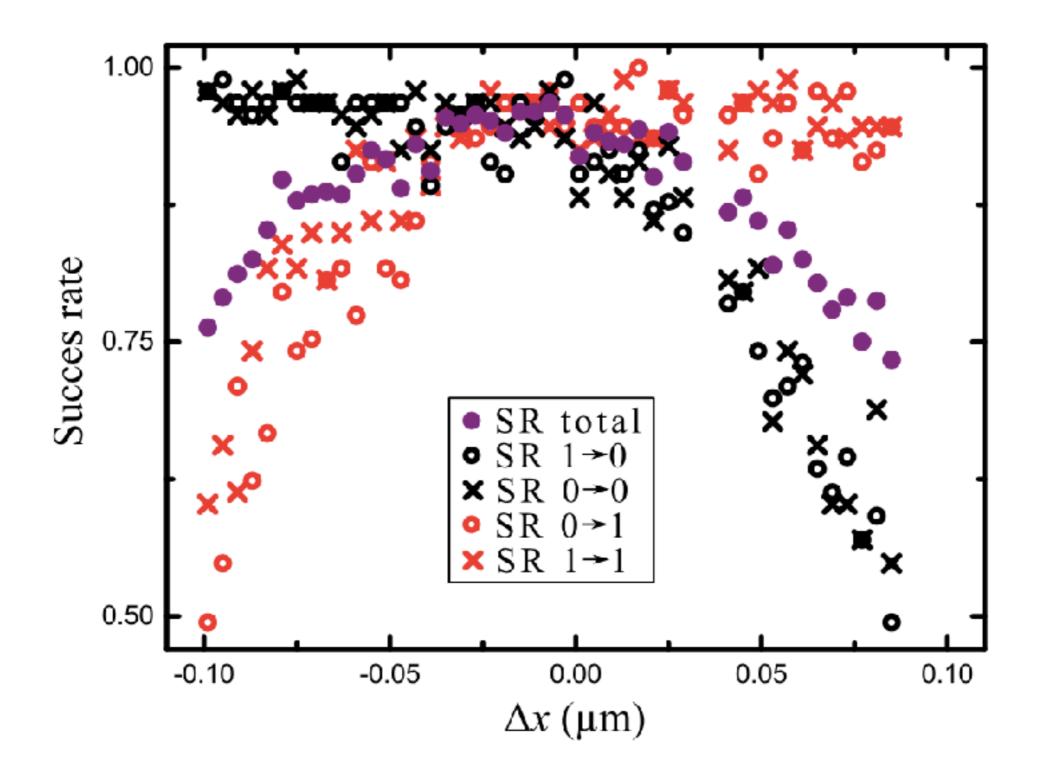


Steps for reset from '0' to '1'

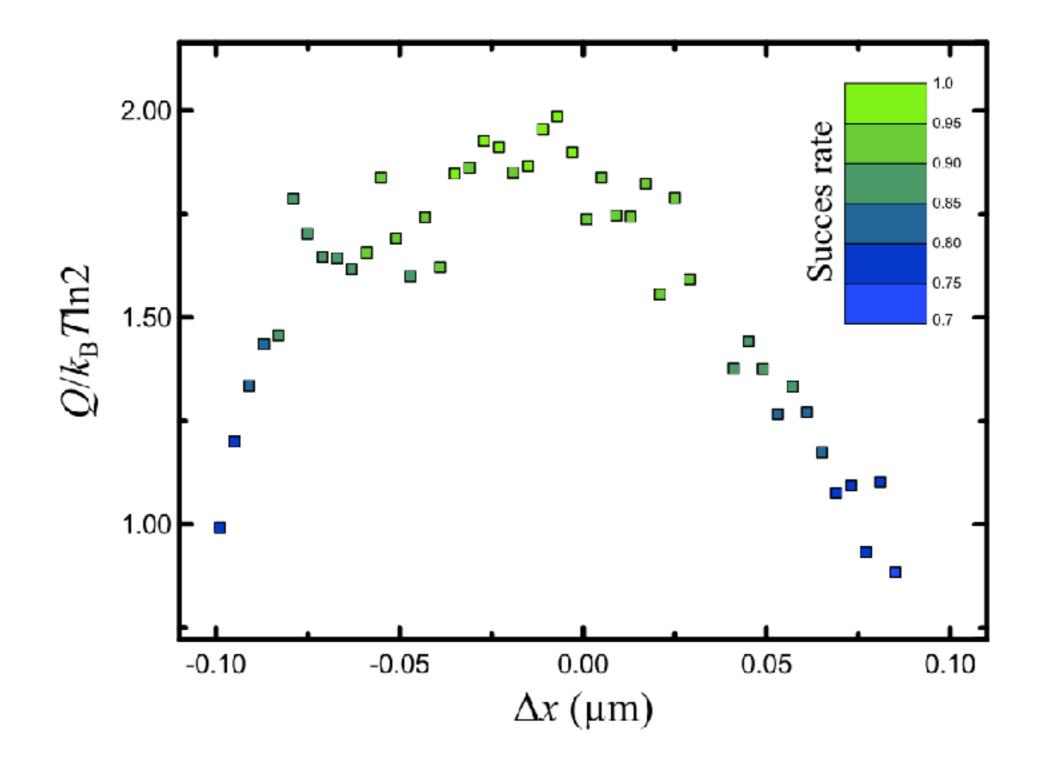
$$W = \int_0^{\tau_{\rm p}} \sum_{k=1}^M \frac{\partial U(x, \lambda)}{\partial \lambda_k} \frac{\partial \lambda_k}{\partial t} dt$$

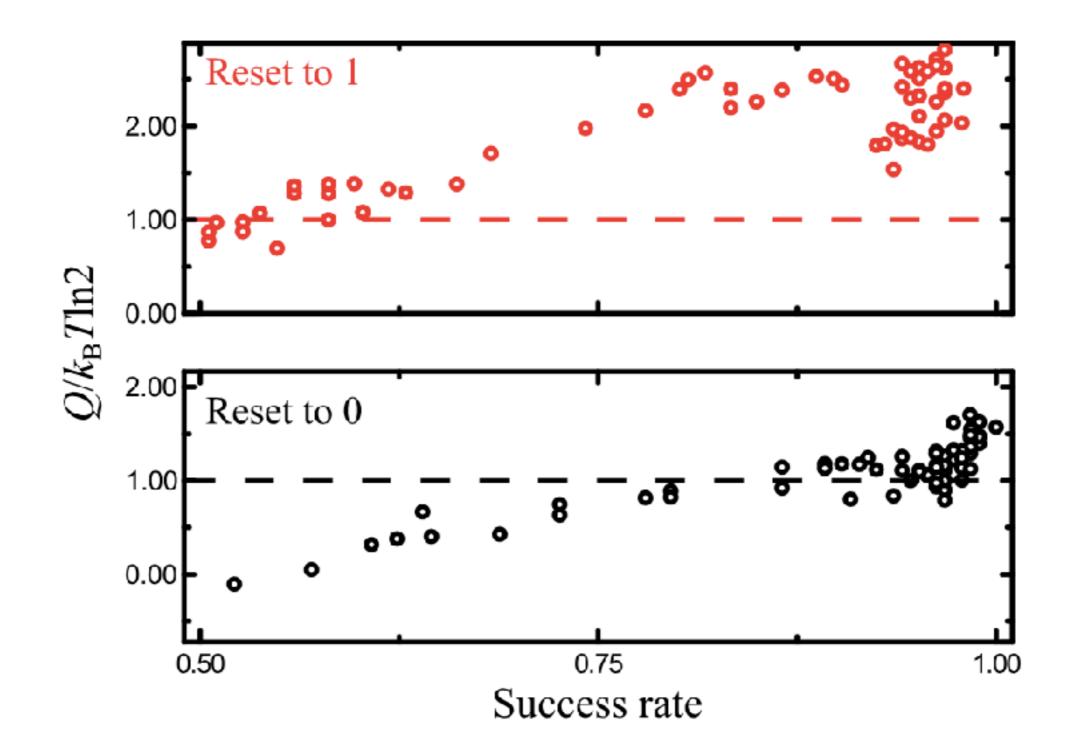
 $Q=W-\Delta U$

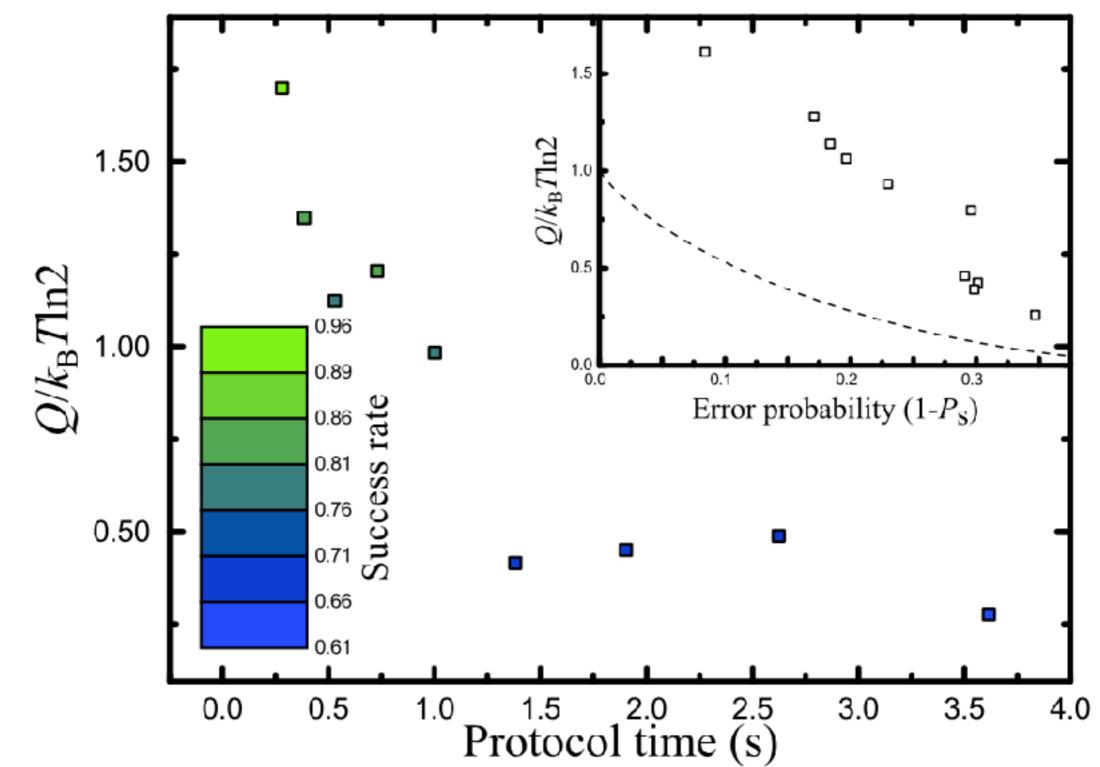
 $Q(P_s) \ge k_B T [\ln(2) + P_s \ln(P_s) + (1 - P_s) \ln(1 - P_s)]$



Neri, Igor, and Miquel López-Suárez. "Heat production and error probability relation in Landauer reset at effective temperature." Scientific Reports 6 (2016).







Neri, Igor, and Miquel López-Suárez. "Heat production and error probability relation in Landauer reset at effective temperature." Scientific Reports 6 (2016).

Thank you for your attention!



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